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RF Exposure Evaluation Report

Product Baby Monitor

VAVA Trade mark

Model/Type reference VA-IH006BU

Serial Number N/A

Report Number EED32L00047502 **FCC ID** 2AFDGVA-IH006A

Date of Issue Jul. 08, 2019

47 CFR Part 1.1307 **Test Standards**

47 CFR Part 1.1310 KDB447498D01v06

Test result PASS

Prepared for:

SUNVALLEYTEK INTERNATIONAL. INC 46724 lakeview Blvd, Fremont, CA 94538

Prepared by:

Centre Testing International Group Co., Ltd. Hongwei Industrial Zone, Bao'an 70 District, Shenzhen, Guangdong, China

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Report Sea

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2 Version

Version No.	Date	Description				
00	Jul. 08, 2019		Original			
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4 General Information

4.1 Client Information

	1				
Applicant:	SUNVALLEYTEK INTERNATIONAL. INC				
Address of Applicant:	46724 lakeview Blvd, Fremont, CA 94538				
Manufacturer:	Shenzhen NearbyExpress Technology Development Co., Ltd.				
Address of Manufacturer:	333 Bulong Road, jialianda Industrial Park, Building 1, Bantain, Longgang District, Shenzhen, China				
Factory:	Foshan Shunde Alford Electronics Co., Ltd				
Address of Factory:	Xinjiao Industrial Park, Daliang, Shunde Foshan City, Guangdong Province, China				

4.2 General Description of EUT

Product Name:	Baby Monitor		
Model No.(EUT):	VA-IH006BU		(3
Trade Mark:	VAVA	(6,2)	(6)
EUT Supports Radios application	2410MHz - 2477MHz		

4.3 Product Specification subjective to this standard

Frequency Range:	2410MHz; 2441.5MHz; 2477MHz				
Modulation Type:	GFSK				
Number of Channels:	20				
Test Power Grade:	N/A		703		
Test Software of EUT:	N/A		(6)		
Antenna Type:	External anter	ina	6		
Antenna Gain:	0dBi				
Power Supply:	AC adapter	Model: VSD0500120VU Input:100-240V~50/60Hz 0.3A Output: 5V 1.2A	(i)		
May Canduated Deals	6.888dBm				
Max Conducted Peak Output Power:	The Max Conducted Peak Output Power data refer to the report EED32L00047501				
Sample Received Date:	Mar. 11, 2019				
Sample tested Date:	Mar. 11, 2019 to Jul. 03, 2019				
The tested sample(s) and t	he sample inform	ation are provided by the client.			



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4.4 Test Location

All tests were performed at:

Centre Testing International Group Co., Ltd

Building C, Hongwei Industrial Park Block 70, Bao'an District, Shenzhen, China

Telephone: +86 (0) 755 33683668 Fax:+86 (0) 755 33683385

No tests were sub-contracted. FCC Designation No.: CN1164

4.5 Deviation from Standards

None.

4.6 Abnormalities from Standard Conditions

None.

4.7 Other Information Requested by the Customer

None.





















































































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5 RF Exposure Evaluation

5.1 RF Exposure Compliance Requirement

5.1.1 Limits

According to FCC Part1.1310: The criteria listed in the following table shall be used to evaluate the environment impact of human exposure to radio frequency (RF) radiation as specified in part1.1307(b)

TABLE 1-LIMITS FOR MAXIMUM PERMISSIBLE EXPOSURE (MPE)

Frequency range (MHz)	Electric field strength (V/m)	Magnetic field strength (A/m)	Power density (mW/cm²)	Averaging time (minutes)
(A) Lim	its for Occupational	/Controlled Exposure	es	
0.3–3.0	614 1842/f	1.63 4.89/f	*(100) *(900/f²)	6
30–300	61.4	0.163	1.0 f/300	6
1500–100,000		***************************************	5	6
(B) Limits t	or General Populati	on/Uncontrolled Exp	osure	
0.3–1.34	614	1.63	*(100)	30
1.34–30	824/f	2.19/f	*(180/f ²)	30
30–300	27.5	0.073	0.2	30
300–1500			f/1500	30
1500-100,000			1.0	30

A rough estimation of the expected exposure in power flux density on a given point can be made with the following equation:

$$S = \frac{P \times G}{4 \times \pi \times R^2}$$

Where:

S = power density

P = power input to the antenna

G = numeric gain of the antenna in the direction of interest relative to an isotropic radiator

R= distance to the centre of radiation of the antenna

EIRP = P*G

The antenna of the product, under normal use condition is at least 20 cm away from the body of the user. Warning statement to the user for keeping at least 20cm separation distance and the prohibition of operating to a person has been printed on the user's manual. Therefore, the S of the device is calculated with R=20cm, and if it is below the limit S, then we can conclude the device complies with the rules.

5.1.2 Test Procedure

Software provided by client enabled the EUT to transmit data at lowest, middle and highest channel individually.











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5.1.3 EUT RF Exposure Evaluation

Antenna Gain: 0dBi

Output Power Into Antenna & RF Exposure Evaluation Distance:

Chanr	el Frequency (MHz)	Max Conducted Peak Output Power(dBm)	Gain (dBi)	EIRP* (dBm)	EIRP (mW)	R (cm)	S (mW/cm²)	Limit (mW/cm²)	Result
Lowe	st 2410	6.888	0	6.888	4.88	20	0.001	1.0	Pass

Note: Refer to report No. EED32L00047501 for EUT test Max Conducted Peak Output Power value.

























































































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PHOTOGRAPHS OF EUT Constructional Details

Refer to Report No. EED32L00047501 for EUT external and internal photos.

*** End of Report ***

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